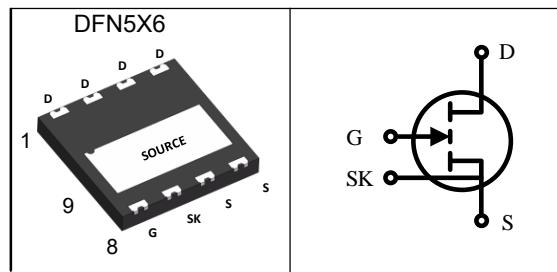


## 650V GaN Enhancement-mode Power Transistor

### Features

- Enhancement mode transistor-Normally off power switch
- Ultra high switching frequency
- No reverse-recovery charge
- Low gate charge, low output charge
- RoHS, Pb-free-compliant

### Pin Description



### Applications

- AC-DC converters
- DC-DC converters
- Totem pole PFC
- Fast battery charging
- High density power conversion

$V_{DSS}$	650	V
$R_{DS(ON)}\text{-Typ}$	140	$\text{m}\Omega$
$I_D$	11.5	A

### Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ , Unless Otherwise Noted)

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain-Source Voltage	650	V
$V_{GSS}$	Gate source voltage, continuous	-1.4 to +7	V
$V_{GSS,\text{pulse}}$	Gate source voltage, pulsed	$\pm 20$	V
$T_J$	Maximum Junction Temperature	-55 to 150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$I_{D,\text{pulse}}$	Pulse Drain Current Tested	20.5	A
$I_D$	Continuous Drain Current	11.5	A
$P_D$	Maximum Power Dissipation	84	W

### Thermal Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	35.9	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance-Junction to Case	1.47	$^\circ\text{C}/\text{W}$

## 650V GaN Enhancement-mode Power Transistor

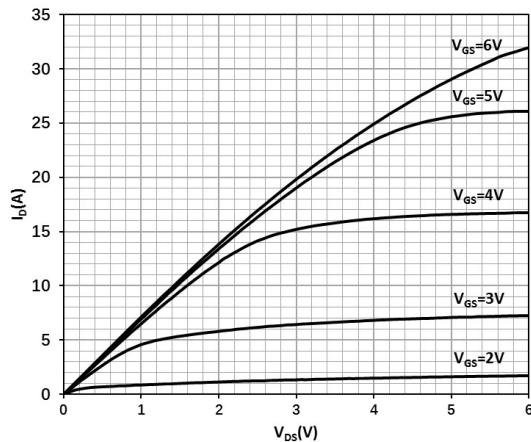
**Electrical Characteristics (T<sub>J</sub>=25°C, Unless Otherwise Noted)**

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
<b>Static Electrical Characteristics</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	650	---	---	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V	---	0.45	20	uA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =12.2mA	1.2	1.7	2.5	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>GS</sub> =6V, V <sub>DS</sub> =0V	---	60	---	uA
R <sub>DS(ON)</sub>	Drain-Source On-state Resistance	V <sub>GS</sub> =6V, I <sub>D</sub> =3.9A	---	140	190	mΩ
<b>Dynamic Characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V, Freq.=1MHz	---	96	---	pF
C <sub>oss</sub>	Output Capacitance		---	30	---	
C <sub>rss</sub>	Reverse Transfer Capacitance		---	0.5	---	
C <sub>o(er)</sub>	Effective output capacitance, energy related	V <sub>DS</sub> =0 to 400V, V <sub>GS</sub> =0V	---	43	---	pF
C <sub>o(tr)</sub>	Effective output capacitance, time related		---	60	---	
Q <sub>oss</sub>	Output charge	V <sub>DS</sub> =0 to 400V, V <sub>GS</sub> =0V	---	24.5	---	nC
T <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DS</sub> =400V, V <sub>GS</sub> =6V, I <sub>D</sub> =8A, R <sub>on</sub> =10Ω, R <sub>off</sub> =2Ω	---	1.4	---	nS
T <sub>r</sub>	Turn-on Rise Time		---	4	---	
T <sub>d(off)</sub>	Turn-off Delay Time		---	1.7	---	
T <sub>f</sub>	Turn-off Fall Time		---	4	---	
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =400V, V <sub>GS</sub> =6V, I <sub>D</sub> =3.9A	---	2.8	---	nC
Q <sub>gs</sub>	Gate-Source Charge		---	0.3	---	
Q <sub>gd</sub>	Gate-Drain Charge		---	1.1	---	
<b>Source-Drain Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =3.9A, V <sub>GS</sub> =0V	---	2.6	---	V
I <sub>S, pulse</sub>	Pulsed current, reverse	V <sub>GS</sub> = 6V; t <sub>PULSE</sub> = 10 μs	---	---	20.5	A
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> =3.9A, V <sub>DS</sub> =400V	---	0	---	nS
Q <sub>rr</sub>	Reverse Recovery Charge		---	0	---	nC
I <sub>rrm</sub>	Peak reverse recovery current		---	0	---	A

## 650V GaN Enhancement-mode Power Transistor

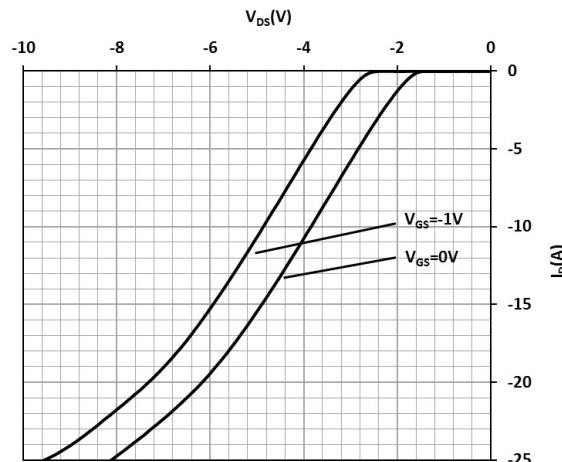
### Typical Characteristics

Figure 1 Typ. output characteristics



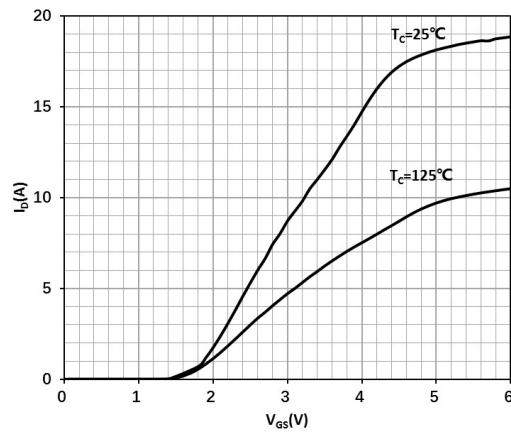
$$I_D = f(V_{DS}, V_{GS}); T_j = 25 \text{ }^\circ\text{C}$$

Figure 3 Typ. channel reverse characteristics



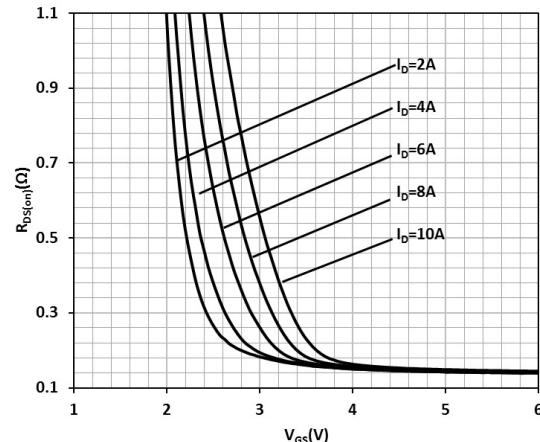
$$I_D = f(V_{DS}, V_{GS}); T_j = 25 \text{ }^\circ\text{C}$$

Figure 5 Typ. transfer characteristics



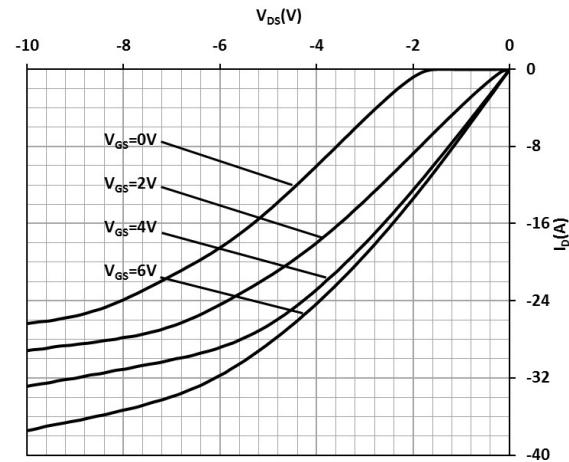
$$I_D = f(V_{GS}); V_{DS} = 3 \text{ V}$$

Figure 2 Typ. Drain-source on-state resistance



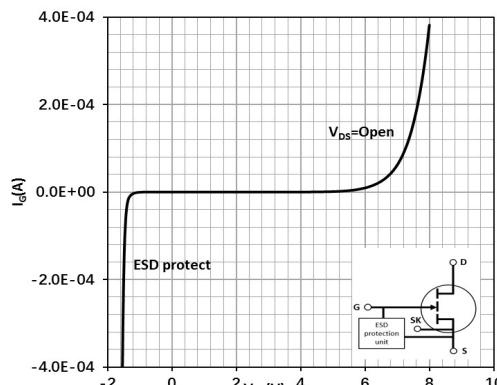
$$R_{DS(on)} = f(I_{DS}, V_{GS}); T_j = 25 \text{ }^\circ\text{C}$$

Figure 4 Typ. channel reverse characteristics



$$I_D = f(V_{DS}, V_{GS}); T_j = 25 \text{ }^\circ\text{C}$$

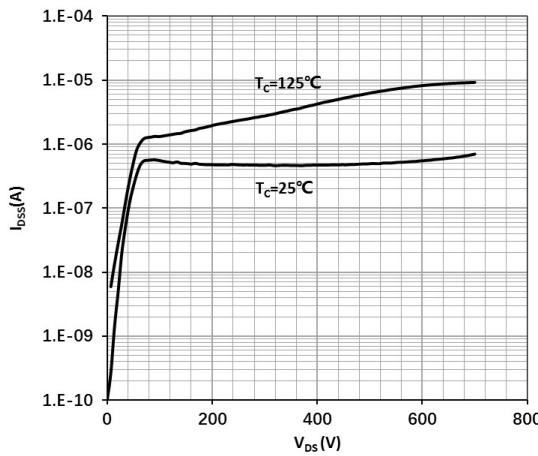
Figure 6 Typ. Gate-to-Source leakage



$$I_G = f(V_{GS}); I_G \text{ reverse turn on by ESD unit}$$

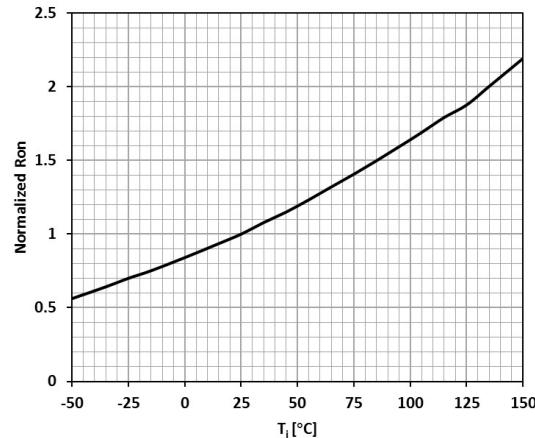
## 650V GaN Enhancement-mode Power Transistor

Figure 7 Drain-source leakage characteristics



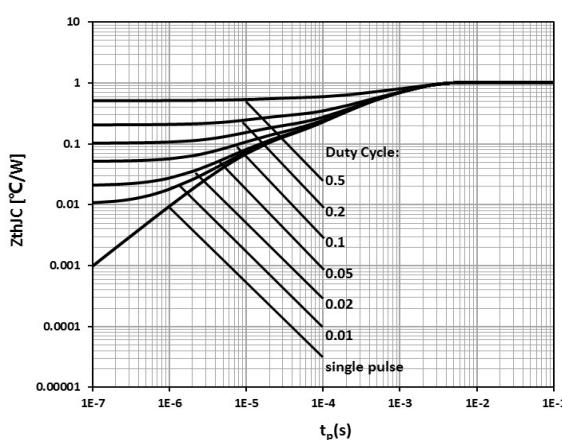
$$I_{DSS} = f(V_{DS}); V_{GS} = 0 \text{ V}$$

Figure 9 Drain-source on-state resistance



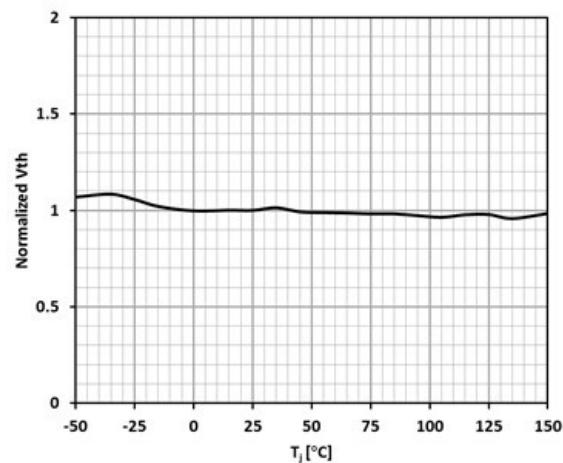
$$R_{DS(on)} = f(T_j); I_D = 3.9 \text{ A}; V_{GS}=6\text{V}$$

Figure 11 Max.transient thermal impedance



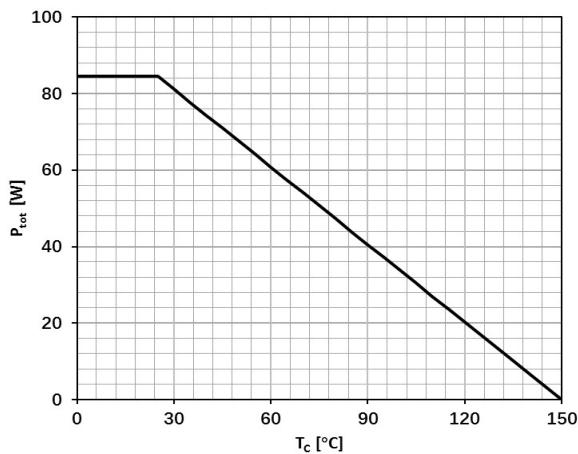
$$Z_{thJC} = f(t_p, D)$$

Figure 8 Gate threshold voltage



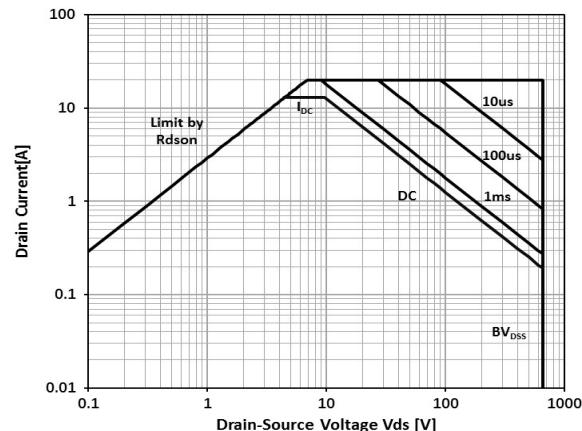
$$V_{TH} = f(T_j); V_{GS} = V_{DS}; I_D = 12.2 \text{ mA}$$

Figure 10 Power dissipation



$$P_{tot} = f(T_c)$$

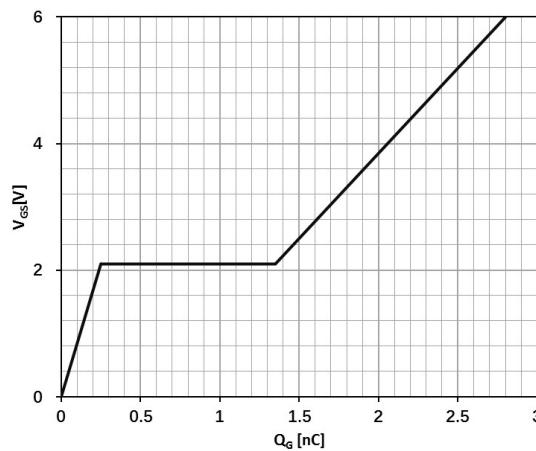
Figure 12 Safe operating area



$$I_D = f(V_{DS}); T_c = 25 \text{ °C}$$

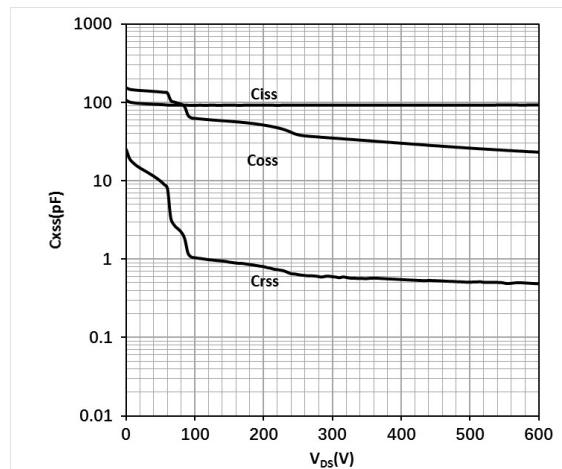
## 650V GaN Enhancement-mode Power Transistor

Figure 13 Typ. gate charge



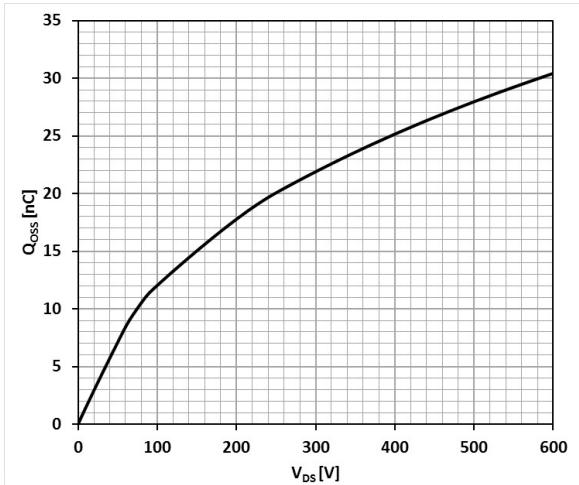
$V_{GS} = f(Q_G)$ ;  $V_{DCLINK} = 400$  V;  $I_D = 5$  A

Figure 14 Typ. capacitances



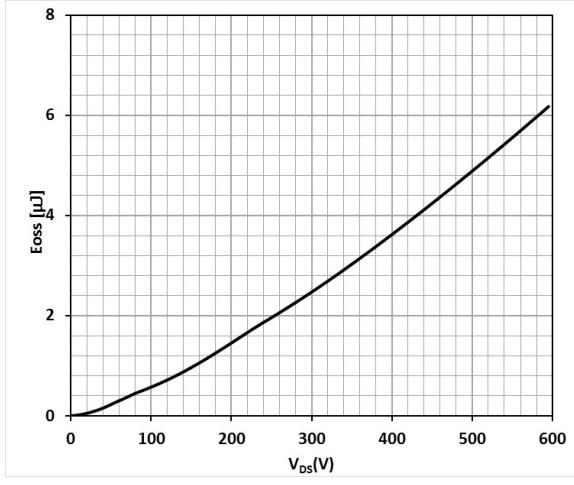
$C_{XSS} = f(V_{DS})$ ; Freq. = 100 kHz Figure

Figure 15 Typ. output charge



$Q_{OSS} = f(V_{DS})$ ; Freq. = 100 kHz

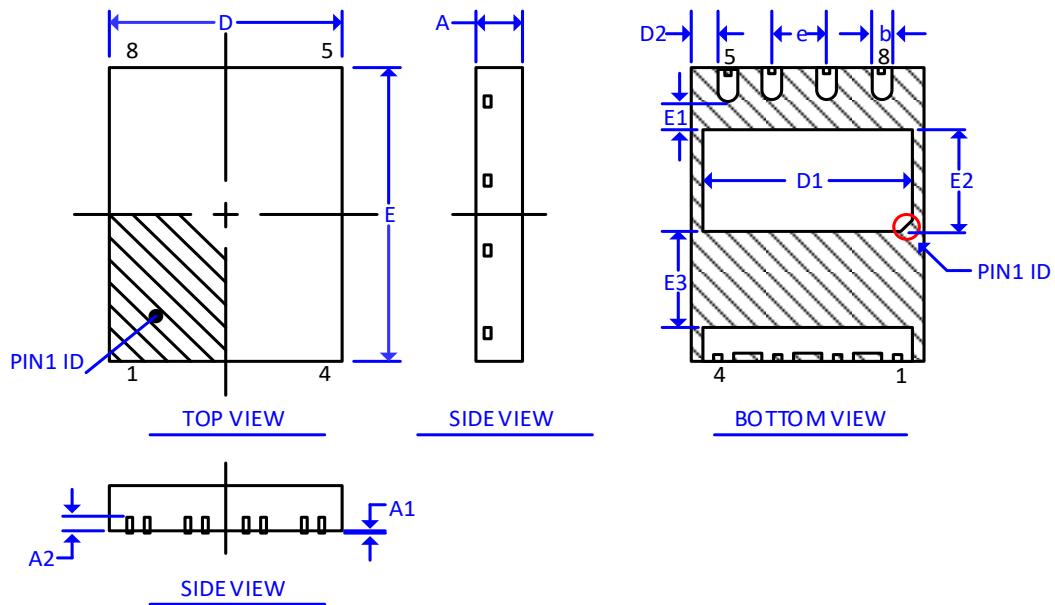
16 Typ. Coss stored Energy



$E_{OSS} = f(V_{DS})$ ; Freq. = 100 kHz

## 650V GaN Enhancement-mode Power Transistor

### DFN5X6 Package Outline Dimensions



SYMBOL	DIMENSION			SYMBOL	DIMENSION		
	MIN	NOM	MAX		MIN	NOM	MAX
A	0.80	0.90	1.00	E	6.00 B.S.C		
A1	0.00	0.02	0.05	E1	0.40	0.50	0.60
A2	---	0.203 ref	---	E2	1.95	2.05	2.15
b	0.40	0.45	0.50	E3	---	2.1	---
D	5.00 B.S.C			e	1.27 B.S.C		
D1	4.16	4.26	4.36	L	0.575	0.675	0.775
D2	0.27	0.37	0.47				